

## GaAs MMIC Wide Voltage Amplifier Chip, 13.5-15GHz

### Performance characteristics

Frequency range: 13.5-15 GHz  
 Wide voltage operation: +5V  
 Small signal gain : 28 dB  
 Gain flatness:  $\pm 0.75$  dB  
 P-1dB: 23.5 dB m  
 Psat: 24 dBm  
 Power supply: +5 V/ 73 mA  
 50Ohm input/output  
 100% on-chip testing  
 Chip size : 1.85 x 1.0 x 0.1mm

### Product Introduction

GPA-1315C is a wide voltage amplifier chip based on GaAs process, covering the frequency range of 13.5~15GHz, small signal gain of 28dB, Psat output power of 24dBm, and efficiency of 46%. The chip is powered by +5V power supply. The chip through-hole metallization process ensures good grounding, and the back side is metallized, which is suitable for eutectic sintering or conductive adhesive bonding process.

#### Use restriction parameter <sup>1</sup>

Maximum drain voltage	+8 V
Maximum input power	+20 dBm
Operating temperature	-55 ~ + 85 °C
Storage temperature	-65 ~ +150°C

【1】 Exceeding any of these maximum limits may cause permanent damage.

#### Electrical performance parameters ( TA = +25°C , Vd = +5V )

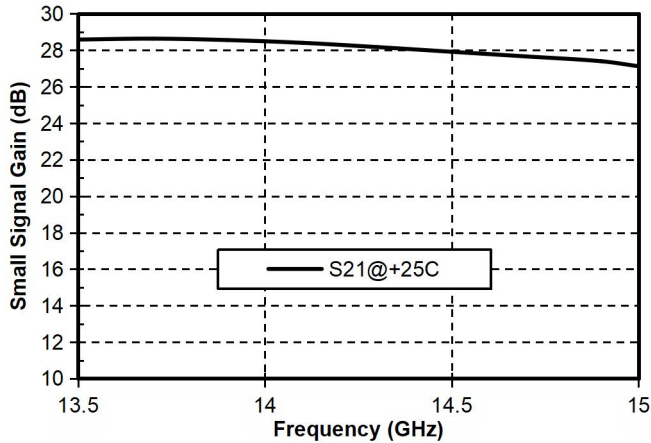
index	Minimum	Typical Value	Maximum	unit
Frequency Range	13.5~15			GHz
Small Signal Gain	-	28	-	dB
Gain Flatness	-	$\pm 0.75$	-	dB
P -1 dB	-	23.5	-	dBm
Psat	-	24	-	dBm
PAE	41	46		%
Input return loss	12	16	-	dB
Output return loss	7.5	17	-	dB
Quiescent Current				mA

\*By tuning the Vg terminal voltage from -2V to 0V, it is recommended that the Vg terminal voltage be expected to be -0.9 V.

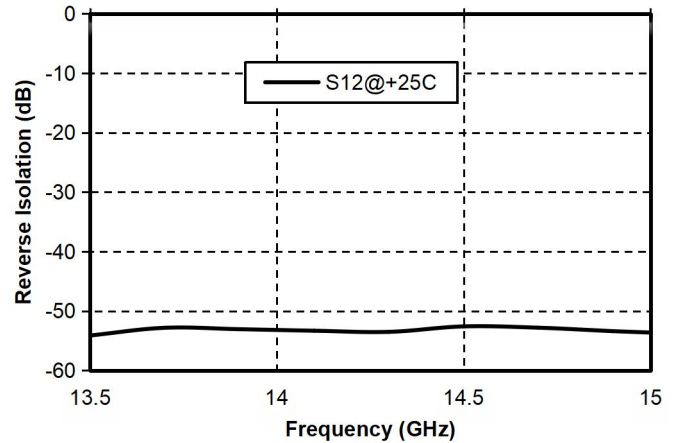
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Main index test curve

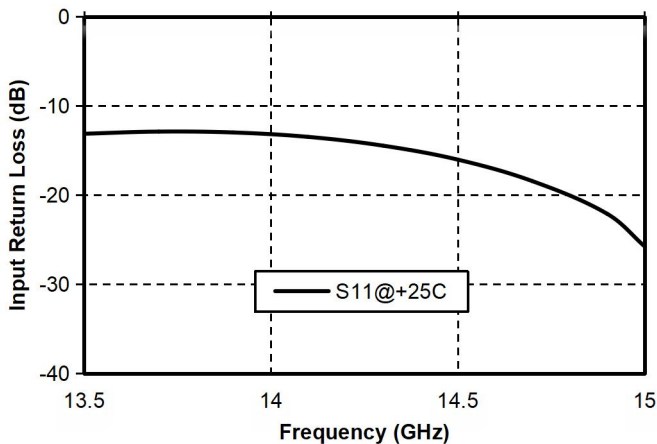
Gain vs. Frequency



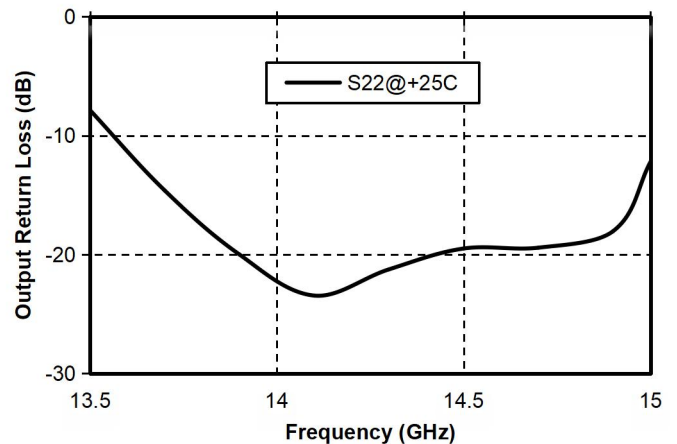
Reverse Isolation vs. Frequency



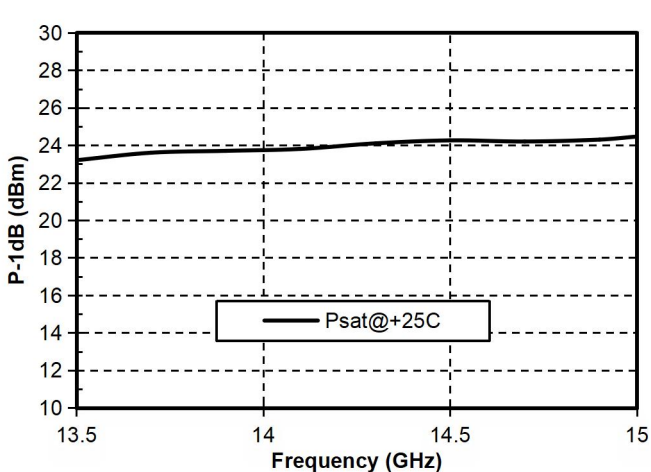
Input Return Loss vs. Frequency



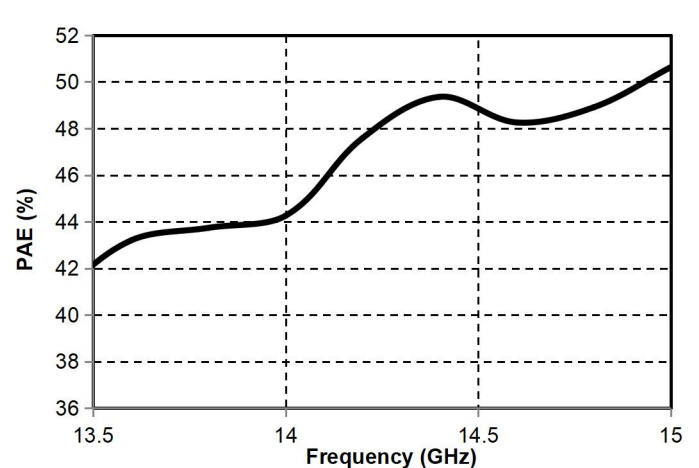
Output Return Loss vs. Frequency



P sat vs. frequency

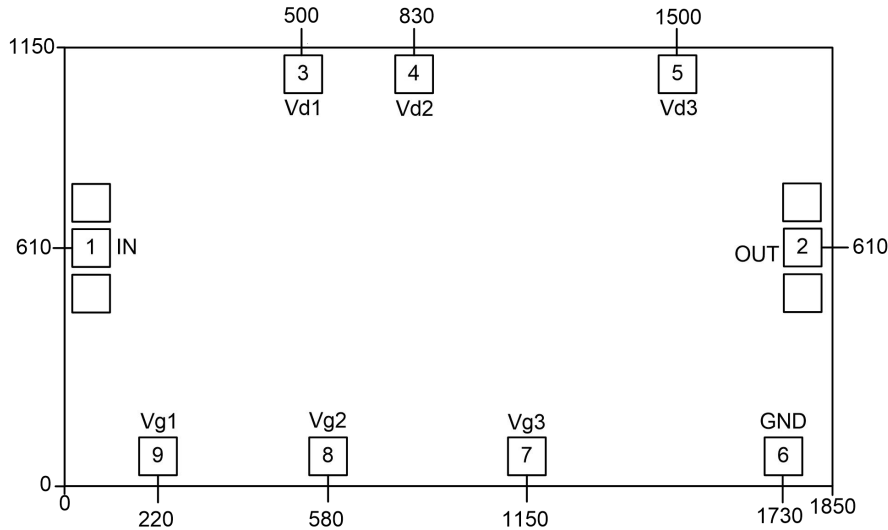


PAE vs. Frequency



## GaAs MMIC Wide Voltage Power Amplifier Chip, 13.5-15GHz

Appearance structure <sup>2</sup>

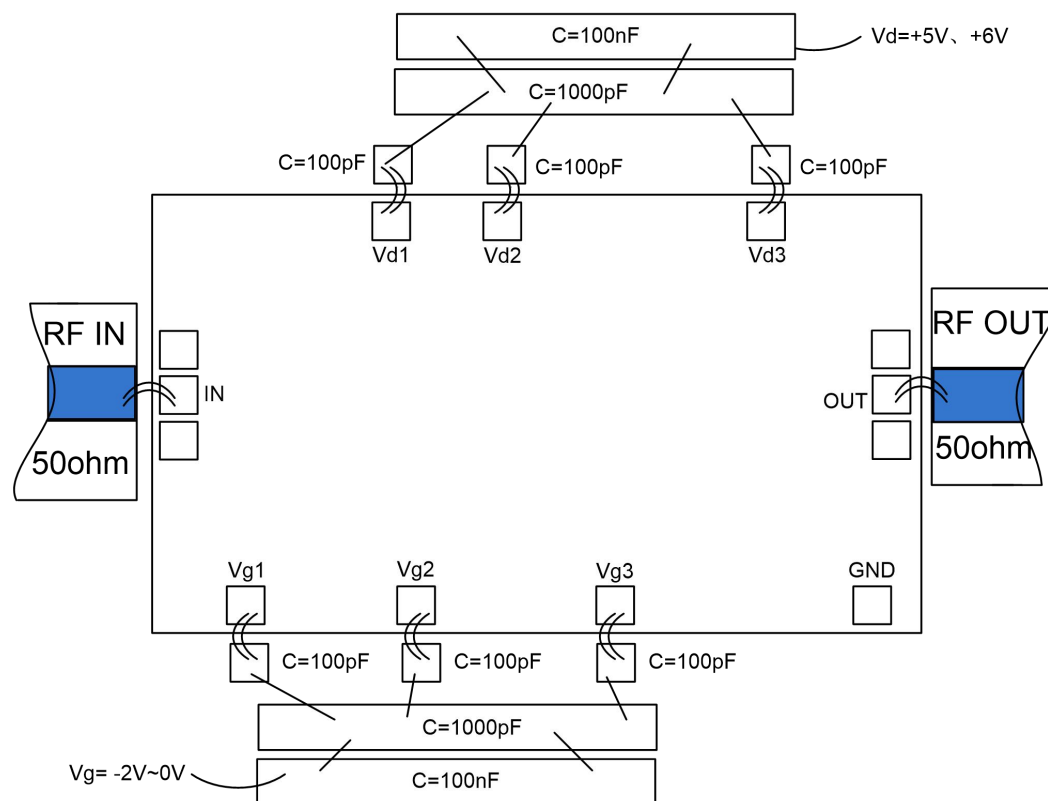


【 2 】 All units in the figure are micrometers

Bonding point definition		
Bonding point number	Function Symbol	Functional Description
1	RF IN	RF signal input terminal, no DC blocking capacitor required
2	RF OUT	RF signal output terminal, no DC blocking capacitor required
3, 4, 5	Vd1 , Vd2, Vd3	Amplifier drain bias, requires external 100 pF, 1000pF, 100nF bypass capacitor
6	GND	Dangling
7, 8, 9	Vg1, Vg2, Vg3	Amplifier gate bias, external 100 pF, 1000 pF, 100 nF bypass capacitor required
Chip bottom	GND	The bottom of the chip needs to be in good contact with the RF and DC grounds

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### Recommended assembly diagram



### Notice

- The chip must be stored in an anti-static container and kept in a nitrogen environment.
- Do not attempt to clean the bare die surface using wet chemical methods.
- Please strictly follow the ESD protection requirements to avoid static damage to the bare chip.
- General operation: Please use precision pointed tweezers to pick up bare chips. Avoid touching the chip surface with tools or fingers during operation.
- Rack mounting operation suggestions: Bare chip mounting can be done by AuSn solder eutectic sintering or conductive adhesive bonding. The mounting surface must be clean and flat.
- Sintering process: It is recommended to use AuSn solder sheets with a gold-tin ratio of 80/20. The working surface temperature reaches 255 °C and the tool (vacuum chuck) temperature reaches 265 °C . When the high-temperature mixed gas (nitrogen-hydrogen ratio of 90/10) is blown to the chip, the temperature at the top of the tool should be raised to 290 °C . Do not let the chip exceed 320 °C for more than 20 seconds. The friction time should not exceed 3 seconds.
- Bonding process: The amount of conductive glue dispensed should be as small as possible. After the chip is placed in the installation position, the conductive glue can be vaguely seen around it. For curing conditions, please follow the information provided by the conductive glue manufacturer.

- Bonding operation suggestions: Use  $\Phi 0.025\text{mm}$  (1mil) gold wire for both ball and wedge bonding. Thermosonic bonding temperature is  $150\text{ }^{\circ}\text{C}$  . The pressure of the wedge bonding knife is 40~50gf for ball bonding and 18~22gf for wedge bonding. Use the smallest possible ultrasonic energy. The bonding starts at the pressure point on the chip and ends at the package (or substrate).